



FQB8N60CF 600V N-Channel MOSFET

Features

- 6.26A, 600V, $R_{DS(on)} = 1.5 \Omega @V_{GS} = 10 V$
- Low gate charge (typical 28nC)
- Low Crss (typical 12pF)
- · Fast switching
- · 100% avalanche tested
- · Improved dv/dt capability
- RoHS Compliant

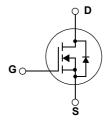


Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, electronic lamp ballasts based on half bridge topology.





Absolute Maximum Ratings

Symbol	Parameter		FQB8N60CF	Units	
V _{DSS}	Drain-Source Voltage		600	V	
I _D	Drain Current - Continuous (T _C = 25°C)		6.26	А	
	- Continuous (T _C = 100°C)		3.96	А	
I _{DM}	Drain Current - Pulsed	(Note 1)	25	А	
V _{GSS}	Gate-Source Voltage		± 30	V	
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	160	mJ	
I _{AR}	Avalanche Current	(Note 1)	6.26	А	
E _{AR}	Repetitive Avalanche Energy (Note 1)		14.7	mJ	
dv/dt	Peak Diode Recovery dv/dt (Note 3)		4.5	V/ns	
P _D	Power Dissipation (T _C = 25°C)		147	W	
	- Derate above 25°C		1.18	W/°C	
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C	
TL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C	

Thermal Characteristics

Symbol	Parameter	FQB8N60CF	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.85	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient*	40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62.5	°C/W

 $^{^{\}star}$ When mounted on the minimum pad size recommended (PCB Mount)

Package Marking and Ordering Information

Device Marking Device		Package	Reel Size	Tape Width	Quantity
FQB8N60CF	FQB8N60CFTM	D2-PAK	330mm	24mm	800

Electrical Characteristics $T_C = 25$ °C unless otherwise noted

Symbol	Parameter Test Conditions		Min	Тур	Max	Units
Off Charac	teristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	600			V
$\Delta BV_{DSS}/$ ΔT_J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C		0.7		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 600 V, V _{GS} = 0 V			10	μА
		V _{DS} = 480 V, T _C = 125°C			100	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30 V, V _{DS} = 0 V			-100	nA
On Charact	eristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 3.13A		1.25	1.5	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 40 V, I _D = 3.13 A (Note 4)		8.7		S
Dynamic Cl	haracteristics					
C _{iss}	Input Capacitance	V _{DS} = 25 V, V _{GS} = 0 V,		965	1255	pF
C _{oss}	Output Capacitance	f = 1.0 MHz		105	135	pF
C _{rss}	Reverse Transfer Capacitance			12	16	pF
Switching C	Characteristics					
t _{d(on)}	Turn-On Delay Time	V _{DD} = 300 V, I _D = 6.26A,		16.5	45	ns
t _r	Turn-On Rise Time	$R_G = 25 \Omega$		60.5	130	ns
t _{d(off)}	Turn-Off Delay Time			81	170	ns
t _f	Turn-Off Fall Time	(Note 4, 5)		64.5	140	ns
Q _g	Total Gate Charge	V _{DS} = 480 V, I _D = 6.26A,		28	36	nC
Q_{gs}	Gate-Source Charge	V _{GS} = 10 V		4.5		nC
Q_{gd}	Gate-Drain Charge	(Note 4, 5)		12		nC
Drain-Source	ce Diode Characteristics and Maximum Ratings	3				
I _S	S Maximum Continuous Drain-Source Diode Forward Current				6.26	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				25	Α
V_{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 6.26 A			1.4	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = 6.26 A,		82		ns
Q _{rr}	Reverse Recovery Charge	$dI_F / dt = 100 A/\mu s$ (Note 4)		242		nC

NOTES:

 $^{{\}bf 1.}\ {\bf Repetitive}\ {\bf Rating: Pulse\ width\ limited\ by\ maximum\ junction\ temperature}$

^{2.} L = 7.3mH, I_{AS} = 6.26A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25°C

^{3.} I $_{SD} \leq$ 6.26A, di/dt \leq 200A/ μ s, V $_{DD} \leq$ BV $_{DSS,}$ Starting T $_{J}$ = 25°C

^{4.} Pulse Test : Pulse width ≤ 300μs, Duty cycle ≤ 2%

^{5.} Essentially independent of operating temperature

Typical Performance Characteristics

Figure 1. On-Region Characteristics

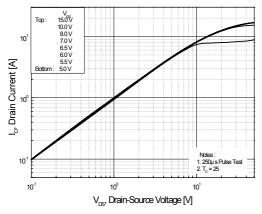


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

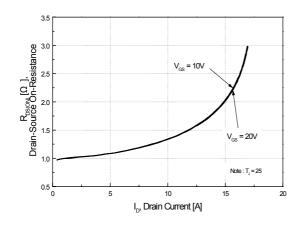


Figure 5. Capacitance Characteristics

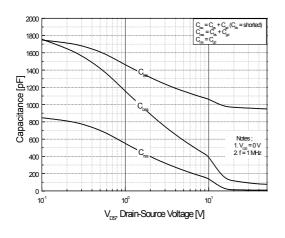


Figure 2. Transfer Characteristics

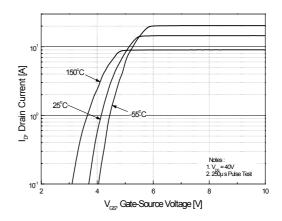


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperatue

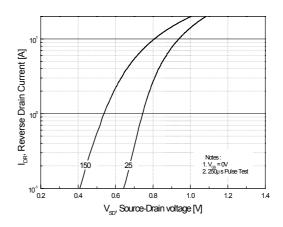
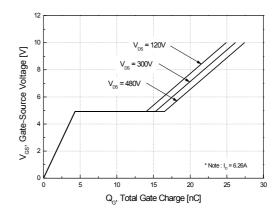


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

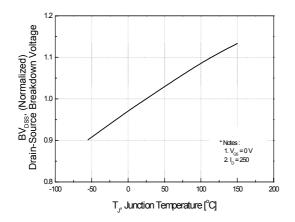


Figure 9. Maximum Safe Operating Area

Figure 8. On-Resistance Variation vs. Temperature

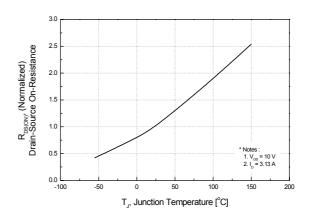


Figure 10. Maximum Drain Current vs. Case Temperature

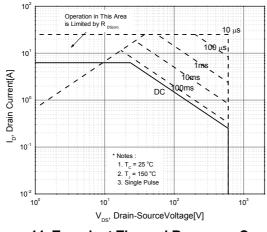
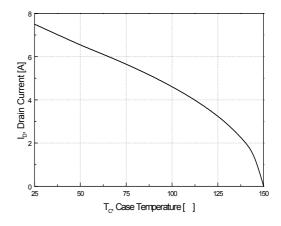
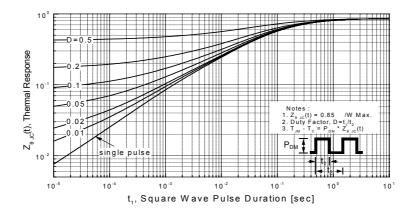
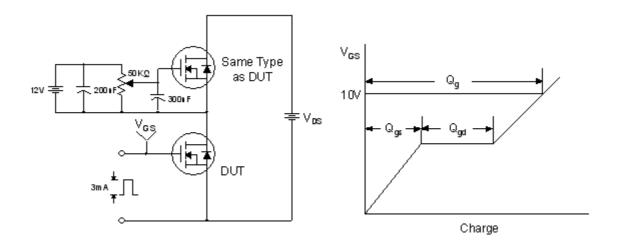


Figure 11. Transient Thermal Response Curve

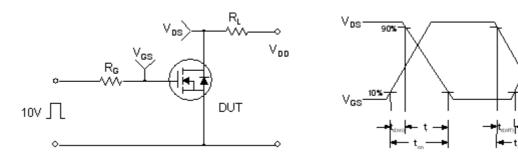




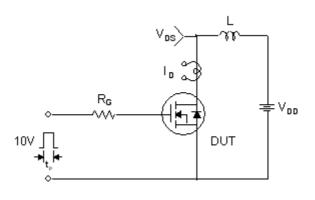
Gate Charge Test Circuit & Waveform

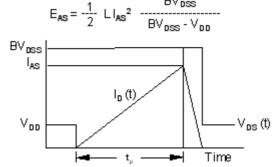


Resistive Switching Test Circuit & Waveforms

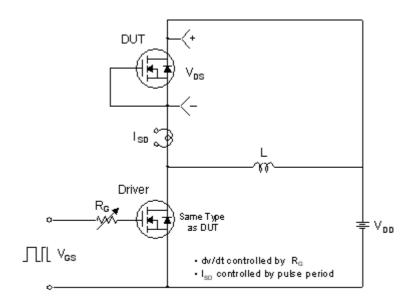


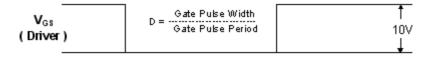
Unclamped Inductive Switching Test Circuit & Waveforms

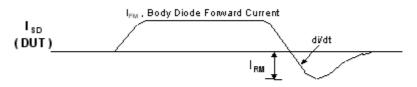


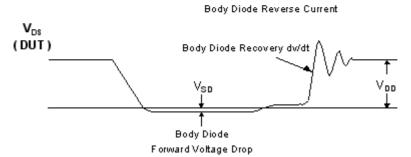


Peak Diode Recovery dv/dt Test Circuit & Waveforms



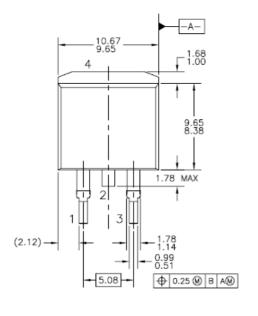


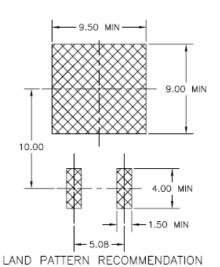




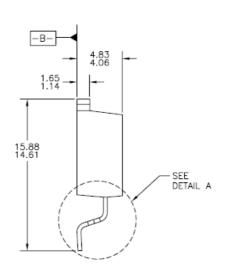
Mechanical Dimensions

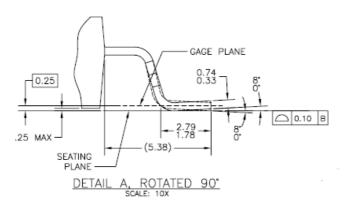
D² - PAK





6.22 MIN 6.86 MIN





Dimensions in Millimeters





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